

Notice of References Cited	Application/Control No. 09/942,255	Applicant(s)/Patent Under Reexamination HOCH ET AL.	
	Examiner Jade O. Laye	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,673,401	09-1997	Volk et al.	725/139
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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